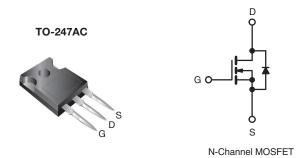


### Power MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	600			
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	1.2		
Q <sub>g</sub> (Max.) (nC)	60			
Q <sub>gs</sub> (nC)	8.3			
Q <sub>gd</sub> (nC)	30			
Configuration	Single			



#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

TO-247AC The package preferred for commercial-industrial applications where higher power levels preclude the use of TO-220AB devices. The TO-247AC is similar but superior to the earlier TO-218 package because of its isolated mounting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247AC
Lead (Pb)-free	IRFPC40PbF
Lead (Pb)-life	SiHFPC40-E3
SnPb	IRFPC40
SILL	SiHFPC40

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	600	V	
Gate-Source Voltage			$V_{GS}$	± 20	1	
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	I <sub>D</sub>	6.8		
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C		4.3	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	27	1	
Linear Derating Factor				1.2	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	410	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		$P_{D}$	150	W	
Peak Diode Recovery dV/dtc			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>	]	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 16 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 6.8$  A (see fig. 12). c.  $I_{SD} \le 6.8$  A,  $I_{AS} = 6.8$  A (see fig. 12).
- d. 1.6 mm from case

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.83	

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		600	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	Reference to 25 °C, I <sub>D</sub> = 1 mA		0.70	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	lana	$V_{DS} = 60$	00 V, $V_{GS} = 0 V$	-	-	100	
Zero date voltage Drain Guirent	I <sub>DSS</sub>	$V_{DS} = 480 \text{ V}, \text{ V}$	V <sub>DS</sub> = 480 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.1 A <sup>b</sup>	-	-	1.2	Ω
Forward Transconductance	9 <sub>fs</sub>	$V_{DS} = 10$	00 V, I <sub>D</sub> = 4.1 A <sup>b</sup>	4.9	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		-	1300	-	pF
Output Capacitance	C <sub>oss</sub>			-	160	-	
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 I	1.0 MHz, see fig. 5		30	-	
Total Gate Charge	$Q_g$		V <sub>GS</sub> = 10 V	-	-	60	nC
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = 10 V		-	-	8.3	
Gate-Drain Charge	$Q_{gd}$		goo ngi o ana ro	-	-	30	
Turn-On Delay Time	t <sub>d(on)</sub>			-	13	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 300 \text{ V, } I_D = 6.2 \text{ A },$ $R_g = 9.1 \ \Omega, \ R_D = 47 \ \Omega, \ \text{see fig. } 10^b$		-	18	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	55	-	
Fall Time	t <sub>f</sub>			-	20	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s	1					
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	6.8	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			_	-	27	
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 6.8  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-		1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 6.2 A, dI/dt = 100 A/µs <sup>b</sup>			450	940	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.8	7.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-	n-on is do	minated b	y L <sub>S</sub> and	L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

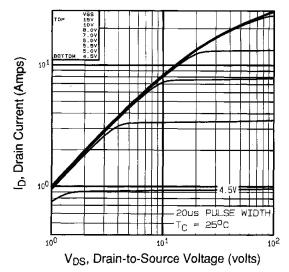


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

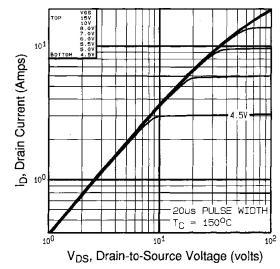


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

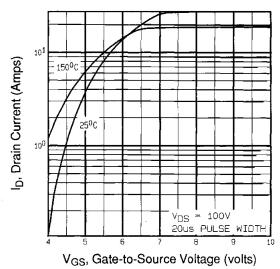


Fig. 3 - Typical Transfer Characteristics

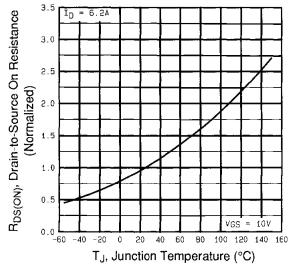


Fig. 4 - Normalized On-Resistance vs. Temperature



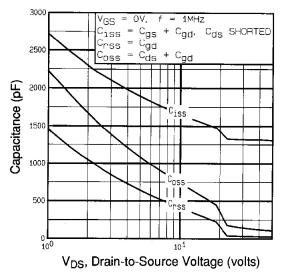


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

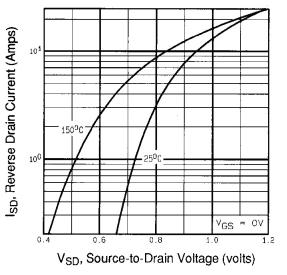


Fig. 7 - Typical Source-Drain Diode Forward Voltage

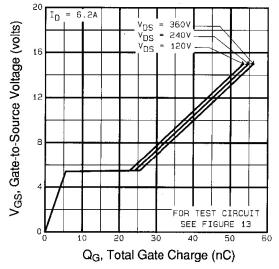


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

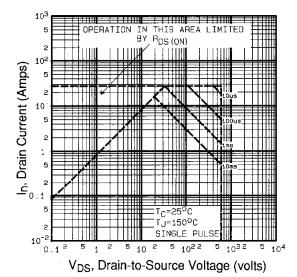


Fig. 8 - Maximum Safe Operating Area





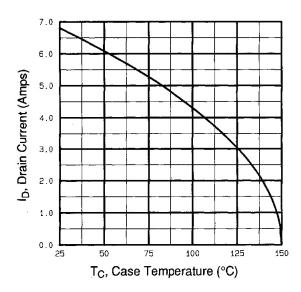


Fig. 9 - Maximum Drain Current vs. Case Temperature

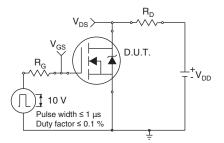


Fig. 10a - Switching Time Test Circuit

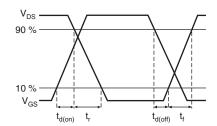


Fig. 10b - Switching Time Waveforms

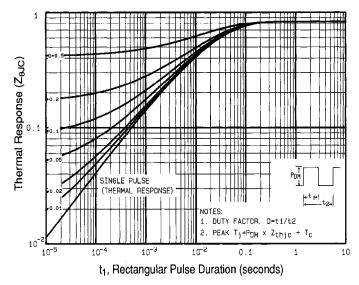
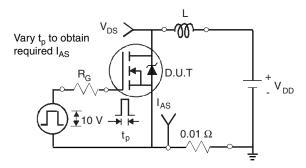


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







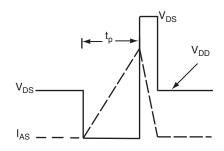


Fig. 12b - Unclamped Inductive Waveforms

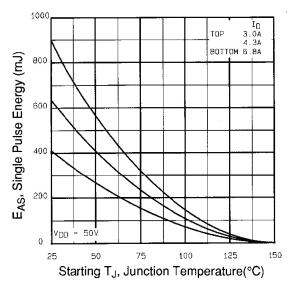


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

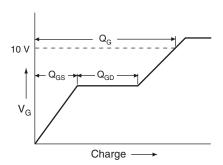


Fig. 13a - Basic Gate Charge Waveform

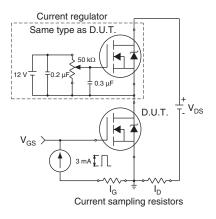
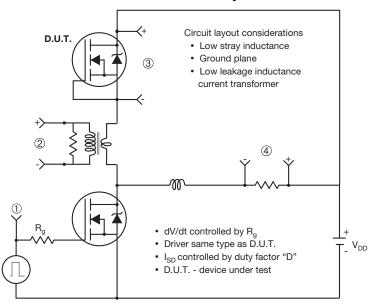


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



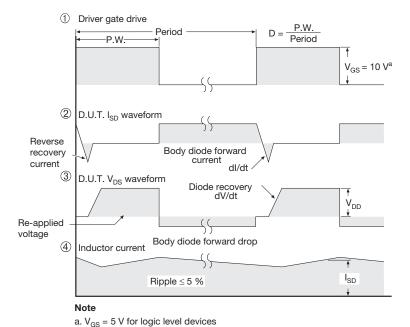


Fig.14 - For N-Channel

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